Notice of References Cited Application/Control No. 10/815,982 Examiner Lev I. Iwashko Applicant(s)/Patent Under Reexamination TRAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0135699 A1	07-2003	Matsuzaki et al.	711/149
*	В	US-2003/0033573 A1	02-2003	Tamura et al.	714/763
*	С	US-2005/0166033 A1	07-2005	Jacob, Rojit	712/011
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-	h = 1		
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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1,9	Р					
	α					
	R			•		
	s					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.